


<b>Search Notes</b>  	<b>Application/Control No.</b>  10711805	<b>Applicant(s)/Patent Under Reexamination</b>  LEANO ET AL.
	<b>Examiner</b>  Edward Chang	<b>Art Unit</b>  4143

SEARCHED			
Class	Subclass	Date	Examiner
705	26	10-15-07	EC
705	38	10-15-07	EC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST -Back Searched related applications from application 0046159A1	10-16-08	EC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
705	26	10-15-07	EC
705	38	10-15-07	EC